

| | | | | |
|-----------------------------------|--|-------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination SCHINDLER ET AL. | |
| | | Examiner Tamthom N. Truong | Art Unit 1624 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| | A | US-5,250,530 | 10-1993 | Giencke et al. | 514/256 |
| | B | US-5,436,233 | 07-1995 | Lee et al. | 514/63 |
| | C | US-5,439,895 | 08-1995 | Lee et al. | 514/63 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------------|----------------|
| | N | 407,899 A2 | 01-1991 | EP | Giencke et. al. | ----- |
| | O | 579,496 A1 | 01-1994 | EP | Lee et. al. | ----- |
| | P | 10-87492 | 04-1998 | JP | Taniguchi et.al. | ----- |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | Albrecht et. al., Chemical Abstracts, Vol. 86, Abstract #29739, 1977. |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

12/3/04